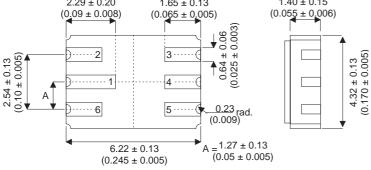




DUAL HIGH FREQUENCY NPN TRANSISTORS IN A HERMETICALLY SEALED **CERAMIC SURFACE MOUNT PACKAGE** FOR HIGH RELIABILITY APPLICATIONS

MECHANICAL DATA Dimensions in mm (inches)

 1.40 ± 0.15 2.29 ± 0.20 1.65 ± 0.13 (0.055 ± 0.006) (0.09 ± 0.008) (0.065 ± 0.005)2



LCC2 PACKAGE (MO-041BB)

Underside View

PAD 1 - Collector 1 PAD 4 - Collector 2 PAD 2 - Base 1 PAD 5 - Emitter 2

PAD 3 - Base 2 PAD 6 - Emitter 1

FEATURES

- SILICON PLANAR EPITAXIAL NPN TRANSISTOR
- HERMETIC CERAMIC SURFACE MOUNT **PACKAGE**
- CECC SCREENING OPTIONS AVAILABLE
- SPACE QUALITY LEVELS AVAILABLE
- HIGH SPEED SATURATED SWITCHING

APPLICATIONS:

For high reliablitity general purpose applications requiring small size and low weight devices.

ABSOLUTE	MAXIMUM RATINGS ($T_c = 25^{\circ}$ C unless otherwise stated)	Per Side	Total Device	
V _{CBO} Collector – Base Voltage		140V		
V_{CEO}	Collector – Emitter Voltage	80V		
V_{EBO}	Emitter – Base Voltage	7V		
$I_{\mathbb{C}}$	Collector Current	1A		
P_{D}	Power Dissipation	350mW	500mW	
P_{D}	Derate above 50°C		3.33mW / °C	
$R_{ heta JA}$	Thermal Resistance Junction to Ambient	429°C / W	300°C / W	
T _j	Max Junction Temperature	200°C		
T _{stg}	Storage Temperature –55°C to 200°C		200°C	

Semelab PIc reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by Semelab is believed to be both accurate and reliable at the time of going to press. However Semelab assumes no responsibility for any errors or omissions discovered in its use. Semelab encourages customers to verify that datasheets are current before placing orders.

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ELECTRICAL CHARACTERISTICS (T_{case} = 25°C unless otherwise stated)

Parameter		Test Conditions		Min.	Тур.	Max.	Unit
V _{(BR)CEO*}	Collector – Emitter BreakdownVoltage	I _C = 10mA	I _B = 0	80			V
V _{(BR)CBO*}	Collector – Base Breakdown Voltage	I _C = 100μA	I _E = 0	140			V
V _{(BR)EBO*}	Emitter – Base Breakdown Voltage	$I_E = 100 \mu A$	I _C = 0	7			V
I _{CBO}	Collector Cut-off Current	V _{CB} = 90V	$V_{BE} = 0$			10	nA
			$T_{amb} = 150$ °C			10	μΑ
I _{EBO}	Emitter Cut-off Current	$V_{EB} = 5V$	·			10	nA
V _{CE(sat)*}	Collector – Emitter Saturation Voltage	I _C = 150mA	I _B = 15mA			0.20	V
		I _C = 500mA	$I_B = 50 \text{mA}$			0.50	
V _{BE(sat)*}	Base – Emitter Saturation Voltage	I _C = 150mA	I _B = 15mA			1.1	
h _{FE*}		$I_C = 0.1 \text{mA}$	V _{CE} = 10V	50			
		I _C = 10mA	V _{CE} = 10V	90			
	DC Current Gain	I _C = 150mA	V _{CE} = 10V	100		300	1 —
			$T_{amb} = -55$ °C	40			
		I _C = 500mA	V _{CE} = 10V	50			
		I _C = 1A	V _{CE} = 10V	15			

^{*} Pulse test $t_p=300\mu s$, $\delta\!\leq\!2\%$

DYNAMIC CHARACTERISTICS (T_{case} = 25°C unless otherwise stated)

	Parameter	Test Conditions			Min.	Тур.	Max.	Unit
f _T	Transition Frequency	$I_C = 50 \text{mA}$	V _{CE} = 10V	f = 20MHz	100			MHz
C _{EBO}	Capacitance	$V_{EB} = 0.5V$	I _C = 0	f = 1.0MHz			60	pF
C _{CBO}	Input Capacitance	V _{CB} = 10V	I _E = 0	f = 1.0MHz			12	pF
h _{fe}	Small Signal Current Gain	$I_C = 1mA$	$V_{CE} = 5V$	f = 1kHz	80		400	_
NF	Noise Figure	$I_{C} = 100 \mu A$	V _{CE} = 10V	f = 1kHz			4	dB
			$R_g = 1K\Omega$					

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